

DAGM 2009

31th Annual Symposium of the German Association for Pattern Recognition
Jena, Germany, September 9-11, 2009

Announcement and Call for Papers

The German Association for Pattern Recognition (Deutsche Arbeitsgemeinschaft für Mustererkennung DAGM e.V.) invites authors and guests to their 31th annual pattern recognition symposium. The meeting will take place at the University of Jena on September 9-11th, 2009. The Chair for Computer Vision of the University Jena and the Fraunhofer Institut of Jena are looking forward to welcoming both renowned experts and newcomers in all areas of pattern recognition and image processing to present and discuss recent progress and advances. The single-track program will leave ample space for discussion; particular importance will be given to the poster sessions to allow for intensive interaction. The first days before will be devoted to the presentation of tutorials in specific emerging areas of pattern recognition. Topics include, but are not limited to:

- Machine Learning and Pattern Recognition
- Image Analysis and Computer Vision
- Mathematical Foundations and Statistical Data Analysis
- Applications in Natural Sciences and Engineering
- Biomedical Data Analysis and Imaging, Biometrics.

Best papers will receive DAGM awards. As local organizers, we are looking forward to a stimulating meeting full of discussions, and we would be happy to welcome you in Jena!

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Further Information

E-mail: info@dagm2009.org

www.dagm2009.org

Important dates

Paper submission deadline:

March 30th, 2009

Notification of acceptance:

May 18th, 2009

Camera ready paper:

June 5th, 2009



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